

MOSFET

StrongIRFET™

Features

- Very low $R_{DS(on)}$ Excellent gate charge x $R_{DS(on)}$ (FOM) Optimized Q_{rr}
- 175°C operating temperature
- Product validation according to JEDEC standard
- Optimized for broadest availability from distribution partners

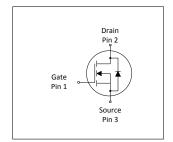
Benefits

- Reduced conduction losses
- Ideal for high switching frequency
- Lower overshoot voltage
 Increased reliability versus 150°C rated parts
- Halogen-free according to IEC61249-2-21

Table 1 **Key Performance Parameters**

| Parameter | Value | Unit |
|---------------------------------|-------|------|
| $V_{ m DS}$ | 100 | V |
| R _{DS(on),typ} | 1.4 | mΩ |
| R _{DS(on),max} | 1.7 | mΩ |
| I _{D(Silicon Limited)} | 316 | A |
| I _{D(Package Limited)} | 203 | A |
| Q _G (0V10V) | 168 | nC |











| Type / Ordering Code | Package | Marking | Related Links |
|----------------------|-------------|------------|---------------|
| IRF100P219 | PG-TO 247-3 | IRF100P219 | - |

StrongIRFET™ IRF100P219



Table of Contents

| Description | . 1 |
|-------------------------------------|-----|
| Maximum ratings | 3 |
| Thermal characteristics | . 3 |
| Electrical characteristics | 4 |
| Electrical characteristics diagrams | 6 |
| Package Outlines | 10 |
| Revision History | 11 |
| Trademarks | 11 |
| Disclaimer | 11 |



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 Maximum ratings

| Davamatar | Cumbal | Values | | | 11 | N | |
|--|-----------------------------------|-----------------------|-------------|-------------------|------|---|--|
| Parameter | Symbol | Symbol Min. Typ. Max. | | Max. | Unit | Note / Test Condition | |
| Continuous drain current | I _D | - - - | - - - | 203 316 224 | A | $V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C (silicon limited) $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C (silicon limited) ¹⁾ | |
| Pulsed drain current ¹⁾ | I _{D,pulse} | - | - | 812 | Α | <i>T</i> _C =25 °C | |
| Avalanche energy, single pulse ²⁾ | E AS | - | - | 464 | mJ | $I_{\rm D}$ =100 A, $R_{\rm GS}$ =50 Ω | |
| Gate source voltage | V _{GS} | -20 | - | 20 | V | - | |
| Power dissipation | P _{tot} | - | - | 341 3.8 | W | T _C =25 °C T _A =25 °C, R _{THJA} =40 °C/W ³⁾ | |
| Operating and storage temperature | T _j , T _{stg} | -55 | - | 175 | °C | IEC climatic category; DIN IEC 68-1: 55/175/56 | |

2 Thermal characteristics

Table 3 **Thermal characteristics**

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|---|-------------------|--------|------|------|------|-----------------------|
| raiailletei | Symbol | Min. | Тур. | Max. | Unit | Note / Test Condition |
| Thermal resistance, junction - case ⁴⁾ | R _{thJC} | - | - | 0.44 | °C/W | - |
| Thermal resistance, junction -Ambient | R _{thJA} | - | - | 40 | °C/W | - |
| Case-to-Sink, Flat Greased Surface | R _{thCS} | - | 0.24 | - | °C/W | - |

See Diagram 3 for more detailed information
 See Diagram 13 for more detailed information
 Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air. $^{4)}$ R_{thJC} is measured at T_J approximately 90°C.



3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Table 4 **Static characteristics**

| Parameter. | 0 | Values | | | 1124 | | |
|---|-----------------------|--------|------------|------------|-------|---|--|
| Parameter | Symbol | Min. | Тур. | Max. | Unit | Note / Test Condition | |
| Drain-source breakdown voltage | V _{(BR)DSS} | 100 | - | - | V | V _{GS} =0 V, I _D =1 mA | |
| Breakdown voltage temperature coefficient | $dV_{(BR)DSS}/dT_{j}$ | - | 40 | - | mV/°C | I _D =2 mA, referenced to 25 °C | |
| Gate threshold voltage | V _{GS(th)} | 2.2 | - | 3.8 | V | V _{DS} =V _{GS} , I _D =278 μA | |
| Zero gate voltage drain current | l _{DSS} | | - | 5 100 | μΑ | V _{DS} =100 V, V _{GS} =0 V, T _j =25 °C V _{DS} =100 V, V _{GS} =0 V, T _j =125 °C | |
| Gate-source leakage current | I _{GSS} | - | - | 100 | nA | V _{GS} =20 V, V _{DS} =0 V | |
| Drain-source on-state resistance | R _{DS(on)} | - | 1.4 1.7 | 1.7 2.1 | mΩ | V _{GS} =10 V, I _D =100 A V _{GS} =6 V, I _D =50 A | |
| Gate resistance ¹⁾ | R _G | - | 1.2 | - | Ω | - | |
| Transconductance | g fs | - | 270 | - | S | V _{DS} ≥2 I _D R _{DS(on)max} , I _D =100 A | |

Table 5 **Dynamic characteristics**

| Paramatan | Oah al | Values | | | | | |
|--|------------------|--------|--------------|---|------|---|--|
| Parameter | Symbol | Min. | Min. Typ. Ma | | Unit | Note / Test Condition | |
| Input capacitance ¹⁾ | Ciss | - | 12000 | - | pF | V _{GS} =0 V, V _{DS} =50 V, f=1 MHz | |
| Output capacitance ¹⁾ | Coss | - | 1800 | - | pF | V _{GS} =0 V, V _{DS} =50 V, f=1 MHz | |
| Reverse transfer capacitance ¹⁾ | C _{rss} | - | 80 | - | pF | V _{GS} =0 V, V _{DS} =50 V, f=1 MHz | |
| Turn-on delay time | $t_{d(on)}$ | - | 30 | - | ns | $V_{\rm DD}$ =50 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G}$ =2.7 Ω | |
| Rise time | t _r | - | 90 | - | ns | $V_{\rm DD}$ =50 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G}$ =2.7 Ω | |
| Turn-off delay time | $t_{ m d(off)}$ | - | 100 | - | ns | $V_{\rm DD}$ =50 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G}$ =2.7 Ω | |
| Fall time | t _f | - | 80 | - | ns | $V_{\rm DD}$ =50 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G}$ =2.7 Ω | |

StrongIRFET™ IRF100P219



Table 6 Gate charge characteristics¹⁾

| Parameter | Cumbal | Values | | | I I m i 4 | Note / Test Condition | |
|------------------------------------|----------------------|--------|------|------|-----------|---|--|
| Parameter | Symbol | Min. | Тур. | Max. | Unit | Note / Test Condition | |
| Gate to source charge | Q _{gs} | - | 53 | - | nC | V_{DD} =50 V, I_{D} =100 A, V_{GS} =0 to 10 V | |
| Gate charge at threshold | $Q_{g(th)}$ | - | 36 | - | nC | V_{DD} =50 V, I_{D} =100 A, V_{GS} =0 to 10 V | |
| Gate to drain charge ²⁾ | Q _{gd} | - | 34 | - | nC | V_{DD} =50 V, I_{D} =100 A, V_{GS} =0 to 10 V | |
| Switching charge | Q _{sw} | - | 51 | - | nC | V_{DD} =50 V, I_{D} =100 A, V_{GS} =0 to 10 V | |
| Gate charge total ²⁾ | Qg | - | 168 | 210 | nC | V_{DD} =50 V, I_{D} =100 A, V_{GS} =0 to 10 V | |
| Gate plateau voltage | V _{plateau} | - | 4.4 | - | V | V_{DD} =50 V, I_{D} =100 A, V_{GS} =0 to 10 V | |
| Gate charge total, sync. FET | Q _{g(sync)} | - | 134 | - | nC | V _{DS} =0.1 V, V _{GS} =0 to 10 V | |
| Output charge ¹⁾ | Q _{oss} | - | 213 | - | nC | V _{DD} =50 V, V _{GS} =0 V | |

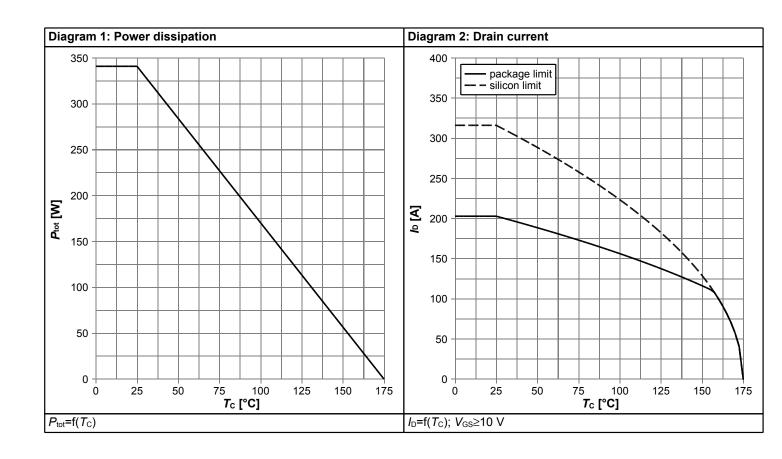
Table 7 Reverse diode

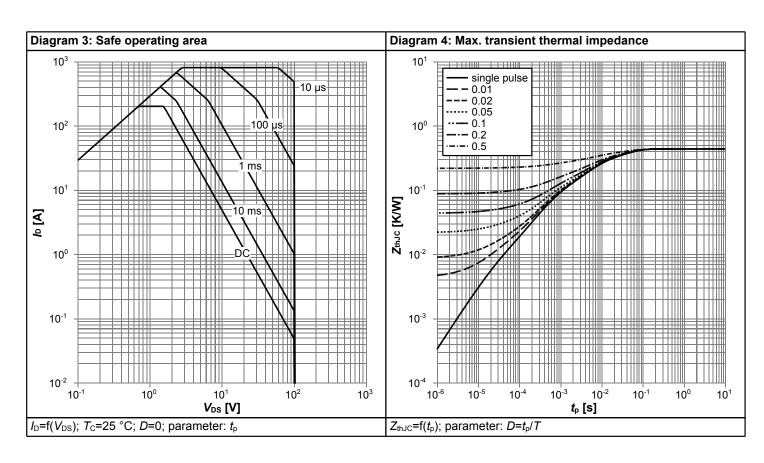
| Parameter | Symbol | Values | | | Unit | Note / Test Condition | |
|---------------------------------------|------------------------|--------|------|------|------|---|--|
| raiailietei | Symbol | Min. | Тур. | Max. | Onit | Note / Test Condition | |
| Diode continuous forward current | Is | - | - | 203 | Α | T _C =25 °C | |
| Diode pulse current | I _{S,pulse} | - | - | 812 | Α | T _C =25 °C | |
| Diode forward voltage | V _{SD} | - | - | 1.2 | V | V _{GS} =0 V, I _F =100 A, T _j =25 °C | |
| Reverse recovery time ²⁾ | t _{rr} | - | 90 | - | ns | V _R =85 V, I _F =100 A, di _F /dt=100 A/μs | |
| Reverse recovery charge ²⁾ | Q _{rr} | - | 224 | - | nC | V _R =85 V, I _F =100 A, di _F /dt=100 A/μs | |

 $^{^{1)}}$ See "Gate charge waveforms" for parameter definition $^{2)}$ Defined by design. Not subject to production test.

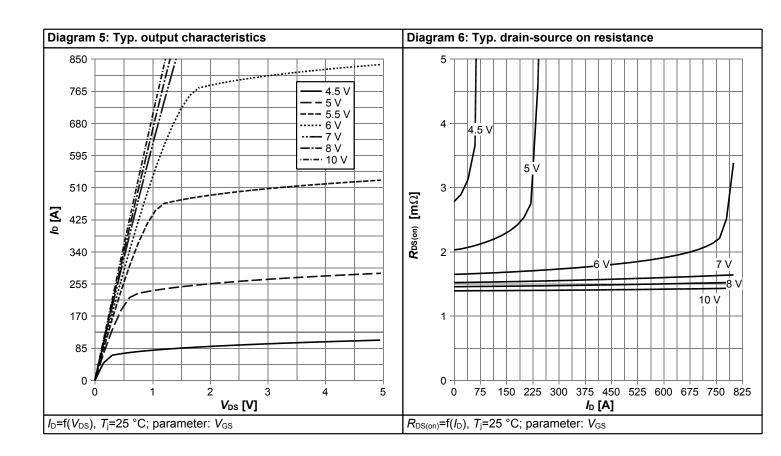


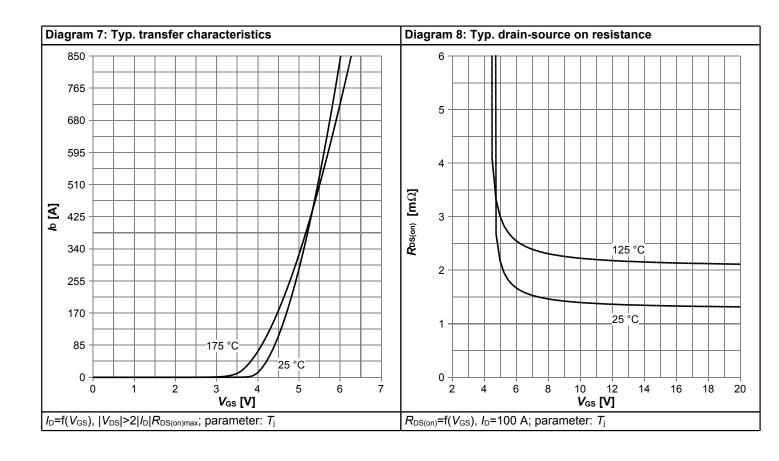
4 Electrical characteristics diagrams



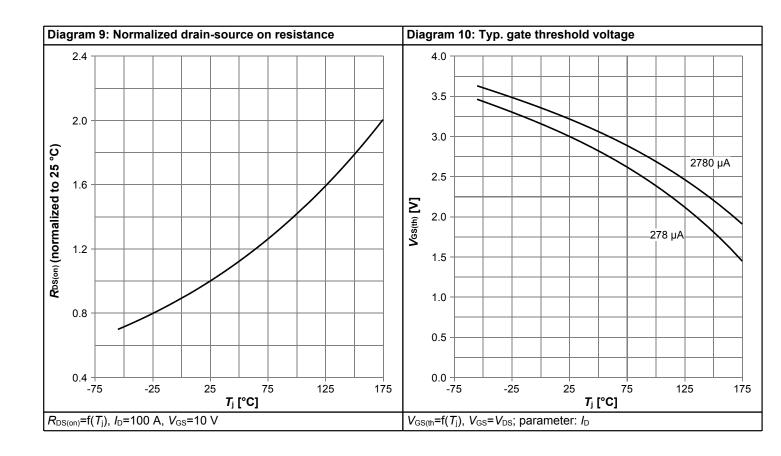


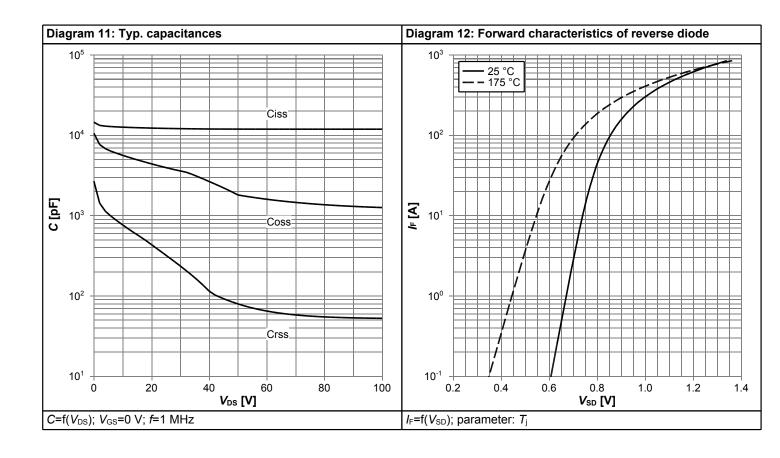




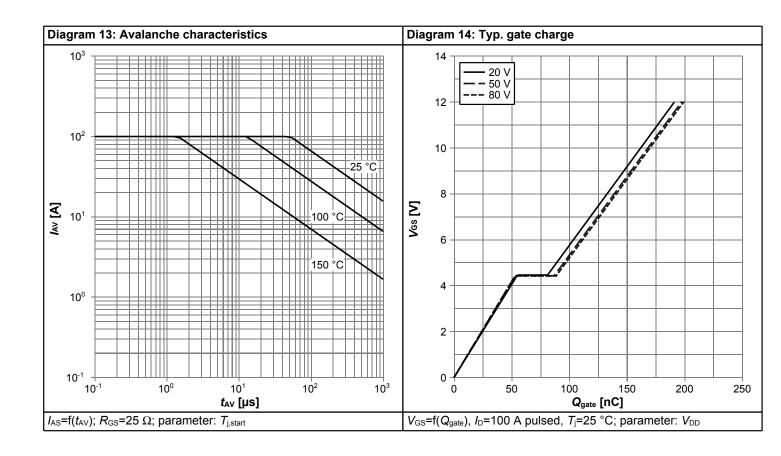


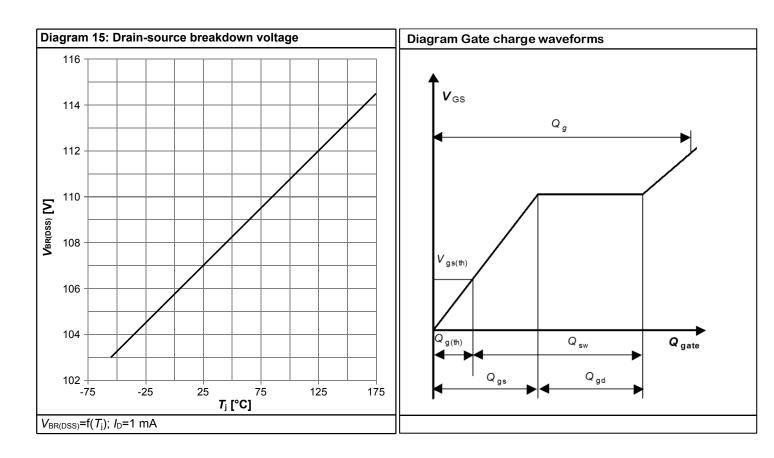






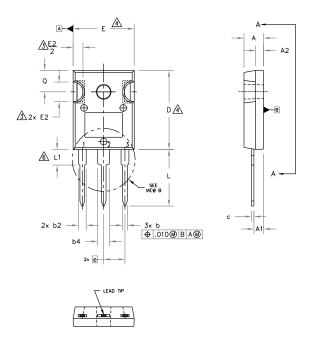


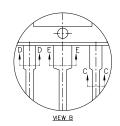


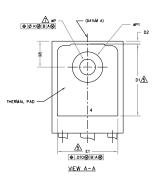




Package Outlines 5







NOTES:

DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.

DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

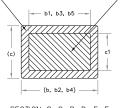
THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

 ${\it \it op}$ to have a Maximum draft angle of 1.5 $^{\rm \circ}$ to the top of the part with a Maximum hole diameter of .154 inch.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

| SYMBOL | INC | HES | MILLIN | | |
|--------|------|------|--------|-------|-------|
| | MIN. | MAX. | MIN. | MAX. | NOTES |
| Α | .183 | .209 | 4.65 | 5.31 | |
| A1 | .087 | .102 | 2.21 | 2.59 | |
| A2 | .059 | .098 | 1.50 | 2.49 | |
| b | .039 | .055 | 0.99 | 1.40 | |
| ь1 | .039 | .053 | 0.99 | 1.35 | |
| b2 | .065 | .094 | 1.65 | 2.39 | |
| b3 | .065 | .092 | 1.65 | 2.34 | |
| b4 | .102 | .135 | 2.59 | 3.43 | |
| b5 | .102 | .133 | 2.59 | 3.38 | |
| С | .015 | .035 | 0.38 | 0.89 | |
| c1 | .015 | .033 | 0.38 | 0.84 | |
| D | .776 | .815 | 19.71 | 20.70 | 4 |
| D1 | .515 | - | 13.08 | - | 5 |
| D2 | .020 | .053 | 0.51 | 1.35 | |
| Ε | .602 | .625 | 15.29 | 15.87 | 4 |
| E1 | .530 | - | 13.46 | - | |
| E2 | .178 | .216 | 4.52 | 5.49 | |
| e | .215 | BSC | 5.46 | BSC | |
| øk | .0 | 10 | 0. | 25 | |
| L | .559 | .634 | 14.20 | 16.10 | |
| L1 | .146 | .169 | 3.71 | 4.29 | |
| øΡ | .140 | .144 | 3.56 | 3.66 | |
| øP1 | - | .291 | - | 7.39 | |
| Q | .209 | .224 | 5.31 | 5.69 | |
| S | .217 | BSC | 5,51 | BSC | |
| | | | | | 1 |



BASE METAL

SECTION C-C, D-D, E-E

LEAD ASSIGNMENTS

| HEXFET | | | | | |
|----------|--|--|--|--|--|
| 1 GATE | | | | | |
| 2 DRAIN | | | | | |
| 3 SOURCE | | | | | |
| 4 DRAIN | | | | | |

IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

DIODES

1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

Figure 1 Outline PG-TO 247-3, dimensions in mm/inches

StrongIRFET™ IRF100P219



Revision History

IRF100P219

Revision: 2020-01-20, Rev. 2.1

Previous Revision

| FIEVIOUS F | Fievious Revision | | | | | | |
|------------|--|---|--|--|--|--|--|
| Revision | Revision Date Subjects (major changes since last revision) | | | | | | |
| 1.0 | 2018-10-03 | Release of preliminary version | | | | | |
| 2.0 | 2018-10-16 | Release of final version | | | | | |
| 2.1 | 2020-01-20 | Update from IR MOSFT/StrongIRFET [™] to StrongIRFET [™] | | | | | |

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com

Published by Infineon Technologies AG 81726 München, Germany © 2020 Infineon Technologies AG All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.